

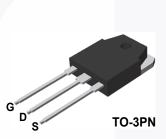
FQA11N90_F109 N-Channel QFET[®] MOSFET 900 V, 11.4 A, 960 mΩ

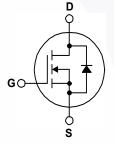
Features

- + 11.4 A, 900 V, $R_{DS(on)}$ = 960 m Ω (Max.) @ V_{GS} = 10 V, I_{D} = 5.7 A
- Low Gate Charge (Typ. 72 nC)
- Low Crss (Typ. 30 pF)
- 100% Avalanche Tested
- RoHS compliant

Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter		FQA11N90_F109	Unit	
V _{DSS}	Drain to Source Voltage			900	V	
I _D	Drain Current	- Continuous (T _C = 25 ^o C)		11.4	A	
	Drain Current	- Continuous (T _C = 100 ^o C)		7.2	A	
DM	Drain Current	- Pulsed	(Note 1)	45.6	A	
V _{GSS}	Gate to Source Voltage			± 30	V	
AS	Single Pulsed Avalanch	e Energy	(Note 2)	1000	mJ	
AR	Avalanche Current		(Note 1)	11.4	A	
E _{AR}	Repetitive Avalanche Er	nergy	(Note 1)	30	mJ	
dv/dt	Peak Diode Recovery d	v/dt	(Note 3)	4.0	V/ns	
P _D	Dower Dissinction	(T _C = 25 ^o C)		300	W	
	Power Dissipation	- Derate Above 25 ^o C		2.38	W/°C	
T _J , T _{STG}	Operating and Storage	Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

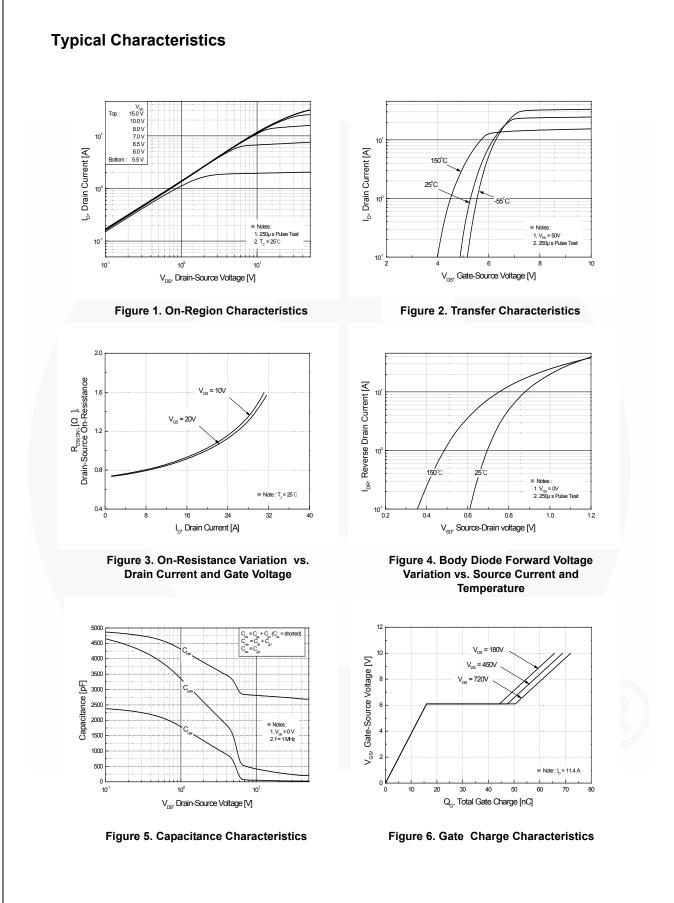
Symbol	Parameter	FQA11N90_F109	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max	0.42	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max	40	°C/W	

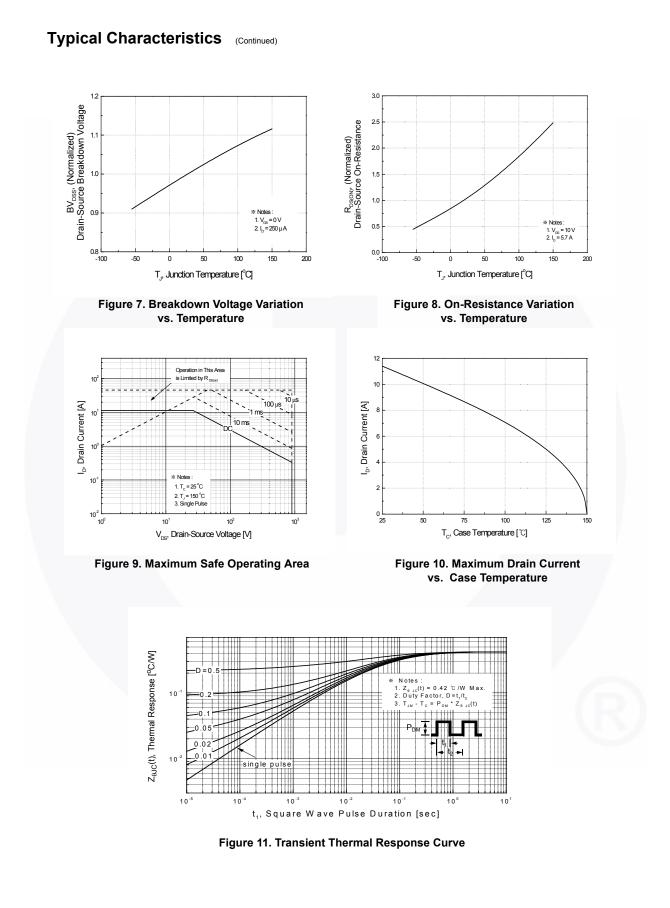
June 2014

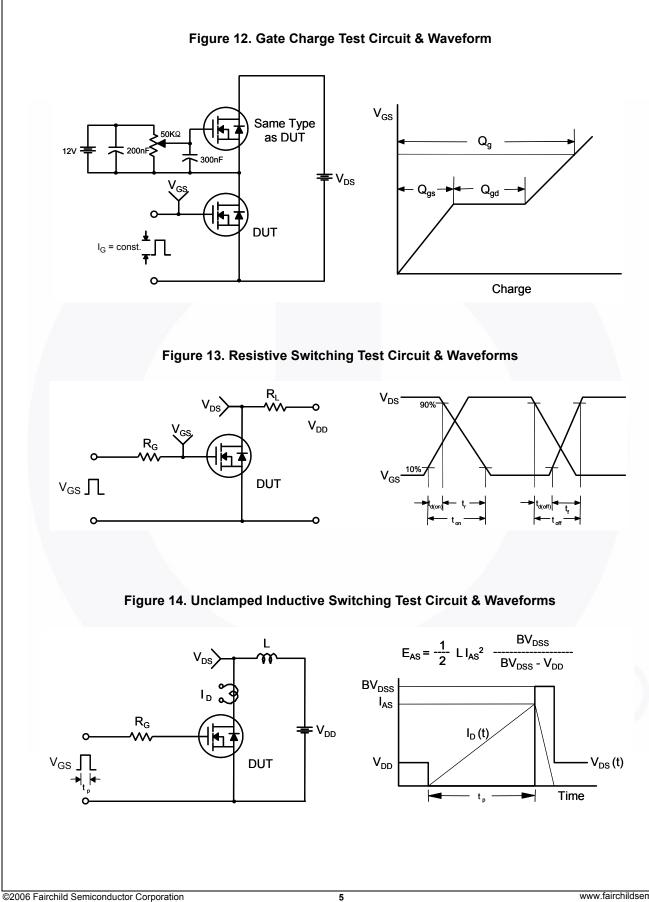
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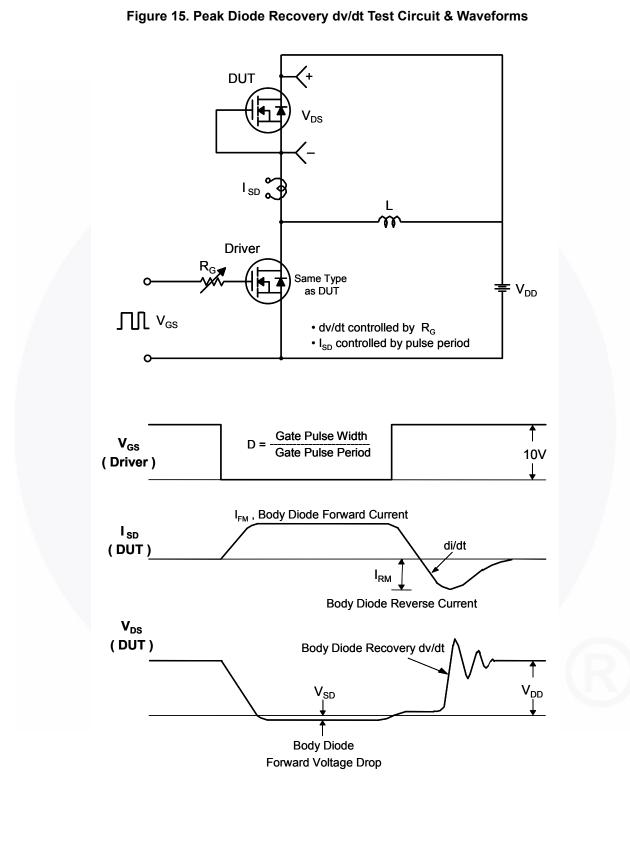
	Device Marking Device FQA11N90 FQA11N90_F1			Packa	ge	Reel S	ize	Tape Widtl	h Qu	antity
			09	TO-3F	-	Tube		N/A		30 units
		eristics T _C = 25°C	C unless o	therwise note			Min	True	Mari	11-1
Symbol Off Cha	racteristics	ameter		Test Cond	litions		Min	Тур	Max	Uni
BV _{DSS}	Drain-Source Bre	akdown Voltage	$V_{GS} = 0$	V, I _D = 250 μ	4		900			V
ΔBV_{DSS} / $\Delta T_{,1}$	Breakdown Voltage Temperature Coefficient		$I_D = 250 \ \mu$ A, Referenced to 25°C				1.0		V/°C	
	Zero Gate Voltage Drain Current		V _{DS} = 9	00 V, V _{GS} = 0	V				10	μA
I _{DSS}				20 V, T _C = 12					100	μA
I _{GSSF}	Gate-Body Leaka	ge Current, Forward	$V_{GS} = 30 V, V_{DS} = 0 V$		1			100	nA	
I _{GSSR}		ge Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$					-100	nA	
On Cha	racteristics									
V _{GS(th)}	Gate Threshold \	/oltage	V _{DS} = V	′ _{GS} , I _D = 250	ιA		3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance		V _{GS} = 10	0 V, I _D = 5.7 A				0.75	0.96	Ω
9 _{FS}	Forward Transconductance		V _{DS} = 50 V, I _D = 5.7 A				12		S	
Dynami C _{iss}	c Characteris		V - 2	5 V, V _{GS} = 0 \	,			2700	3500	pF
C _{oss}	Output Capacitar		f = 1.0 M		,			260	340	pF
C _{rss}	Reverse Transfer		1 1.01	11 12		•		30	40	pF
	ng Characteri	stics								
t _{d(on)}	Turn-On Delay Ti	me	Vpp = 4	50 V, I _D = 11.4	A.			65	140	ns
t _r	Turn-On Rise Tin	ne	R _G = 25	-	,			135	280	ns
t _{d(off)}	Turn-Off Delay Ti	me	Ŭ					165	340	ns
t _f	Turn-Off Fall Time	9				(note 4)		90	190	ns
Qg	Total Gate Charg	e	V _{DS} = 7	20 V, I _D = 11.4	Α,			72	94	nC
Q _{gs}	Gate-Source Cha	irge	V _{GS} = 10 V				16		nC	
Q _{gd}	Gate-Drain Char	je				(note 4)		35		nC
Drain-S	ource Diode C	haracteristics ar	nd Maxi	mum Ratir	ngs					
I _S	Maximum Continuous Drain-Source Diode Forward Current								11.4	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current							45.6	A	
V _{SD}	Drain-Source Dio	de Forward Voltage		V, I _S = 11.4 A					1.4	V
t _{rr}	Reverse Recover	ry Time	V _{GS} = 0 V, I _S = 11.4 A,			850		ns		
	Reverse Recover		dI _F / dt = 100 A/µs				11.2		μC	

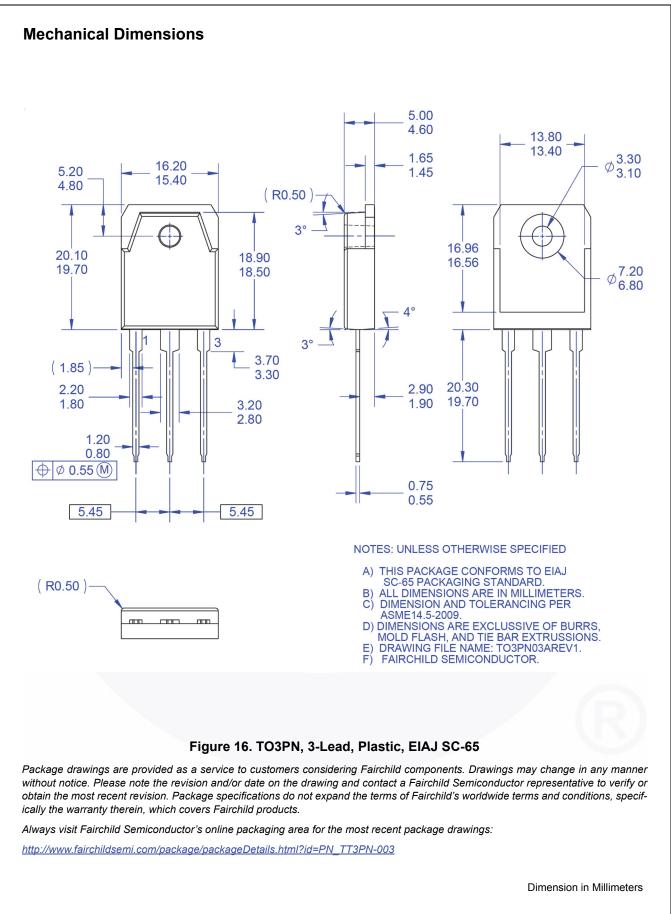
4. Essentially independent of operating temperature.













Not In Production

Obsolete

Datasheet contains specifications on a product that is discontinued by Fairchild

Semiconductor. The datasheet is for reference information only.